

USPTO Form 1449 AUG 26 2003 INFORMATION DISCLOSURE CITATION Page 1 of 6		U.S. Department of Commerce Patent and Trademark Office		Attorney Docket No. 4522/00019		Serial No. 10/621,247	
				Applicant(s): Wikel, et al.			
				Filing Date: July 16, 2003		Group:	
U.S. PATENT DOCUMENTS							
Examiner Initial		Patent No.	Date	Name	Class	Subclass	Filing Date (if appropriate)
<i>HW</i>	AA	4,917,774	April 17, 1990	Fisher	204	153.1	
<i> </i>	AB	5,298,129	March 29, 1994	Eliash	204	153.1	
<i> </i>	AC	5,223,118	June 29, 1993	Sonnenberg, et al.	205	81	
<i> </i>	AD	5,192,403	March 9, 1993	Chang, et al.	204	153.1	
<i> </i>	AE	5,196,096	March 23, 1993	Chang, et al.	204	153.1	
<i> </i>	AF	4,631,116	December 23, 1986	Ludwig	204	1 T	
<i> </i>	AG	4,812,210	March 14, 1989	Bonivert, et al.	204	1 T	
<i> </i>	AH	5,298,131	March 29, 1994	Eliash, et al.	204	153.1	
<i> </i>	AI	5,336,380	August 9, 1994	Phan, et al.	204	153.1	
<i>VL</i>	AJ	5,755,954	May 26, 1998	Ludwig, et al.	205	794	
NON PATENT LITERATURE DOCUMENTS							
(Include the name of the Author, (IN CAPITAL LETTERS), title of the Article (when appropriate), title of the item, date, page(s), volume issue number(s), publisher, city and/or country where published.)							
<i>HW</i>	AK	HAAK, et al. "Cyclic Voltammetric Stripping Analysis of Acid Copper Sulfate Plating Baths, Part One Polyether-Sulfate-Based Additives", Tench Plating and Surface Finishing, 68 (4) 1981, 52.					
<i> </i>	AL	HAAK, et al. "Cyclic Voltammetric Stripping Analysis of Acid Copper Sulfate Plating Baths, Part Two, Sulfoniumalkanesulfonate-Based Additives", Tench Plating and Surface Finishing, 69 (3) 1982, 62.					
<i> </i>	AM	GRAHAM & LINDBERG, "Steady-State Chemical Analysis of Organic Suppressor Additives used in Copper Plating Baths", ECS Meeting Honolulu, 1999, Abstract # 729.					
<i> </i>	AN	FREITAG, et al. "Determination of the Individual Additive Components in Acid Copper Plating Baths", Plating and Surface Finishing, 70, 10, 1983, 55.					
<i> </i>	AO	TEÑCH & WHITE, "Cyclic Pulse Voltammetric Stripping Analysis Of Acid Copper Plating Baths", J. Electrochem. Soc., 132, 4, 1985, 831.					
<i> </i>	AP	KRAFCIK, et al. "An In-Situ Sensor for Monitoring Organic Additives in Copper Plating Solutions", Proceedings of the World Congress on Metal Finishing, Interfinish 92, International Union of Surface Finishing, Brasil, October 1992.					
<i> </i>	AQ	NEWTON & KAISER, "Analysis of Copper Plating Baths - New Developments", ECS Meeting Toronto, 1999, Abstract # 357.					
<i> </i>	AR	HORKANS & DUKOVIC, "Monitoring of SPS-Based Additives in Cu Plating", ECS Meeting Toronto, 1999, Abstract # 360.					
<i>WL</i>	AS	BROWN & BEAR, "Chemometric Techniques in Electrochemistry: A Critical Review", Critical Reviews in Analytical Chemistry, 24(2):99-131, 1993.					
EXAMINER <i>Danny A. Witt III</i>				DATE CONSIDERED 12/23/05			
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant. **Copies of references not provided at the time of this submission.</small>							

USPTO Form 1449 AUG 26 2003 PATE INFORMATION DISCLOSURE CITATION TRADEPAGE 2 of 6		U.S. Department of Commerce Patent and Trademark Office		Attorney Docket No. 4522/00019	Serial No. 10/621,247
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HW	AT	NI, et al. "Simultaneous Polarographic Analysis of Pyrazine and its Methyl Derivatives by Iterative Target Transformation Factor Analysis", Analytica Chimica Acta 316 (1995) 233-238.			
	AU	NI, et al. "Simultaneous Adsorptive Voltammetric Analysis of Mixed Colorants by Multivariate Calibration Approach", Analytica Chimica Acta 329, 1996, 65-72.			
	AY	NI, et al. "Multicomponent Chemometric Determination of Colorant Mixtures by Voltammetry", Analytical Letters, 30(9), 1761-1777, 1997.			
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	AX	NI, et al. "Voltammetric Determination of Chlorpromazine Hydrochloride and Promethazine Hydrochloride with the Use of Multivariate Calibration", Analytica Chimica Acta 439, 2001, 159-168.			
	AY	LOMILLO, et al. "Resolution of Ternary Mixtures of Rifampicin, Isoniazid and Pyrazinamide by Differential Pulse Polarography and Partial Least Squares Method", Analytica Chimica Acta 449, 2001, 167-177.			
	AZ	ALLUS and BRERETON, "Determination of Thallium in Cement Dust and Sediment Samples by Differential-Pulse Anodic Stripping Voltammetry: A Chemometric Approach to Linear Calibration", Analyst, July 1992, Vol. 117.			
	BA	CABANILLAS, et al. "Resolution of Ternary Mixtures of Nitrofurantoin, Furzolidone and Furaltadone by Application of Partial Least Squares Analysis to the Differential Pulse Polarographic Signals", Talanta, Vol. 41, No. 11, pp. 1821-1832, 1994			
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	BD	GUIBERTEAU, "Indirect Voltammetric Determination of Carbaryl and Carbofuran Using Partial Least Square Calibration", Analytica Chimica Acta, 305, 1995, 219-226.			
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	BF	CABANILLAS, et al. "Resolution by Polarographic Techniques of Atrazine-Simazine and Terbutryn-Prometryn Binary Mixtures by Using PLS Calibration and Artificial Neural Networks", Analyst, 2000, 125, 909-914.			
	BG	LASTRES, et al. "Use of Neural Networks in Solving Interferences Caused by Formation of Intermetallic Compounds in Anodic Stripping Voltammetry", Electroanalysis, 1997, 9, No. 3.			
HW	BH	CHAN, et al. "Artificial neural network Processing of Stripping Analysis Responses for Identifying and Quantifying Heavy Metals in the Presence of Intermetallic Compound Formation", Anal. Chem., 1997, 69, 2373-2378.			
EXAMINER <i>Haung S. Witt, III</i>			DATE CONSIDERED 12/23/05		
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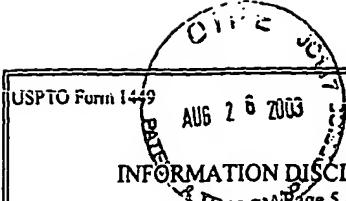
<i>HW</i>	BI	RICHARDS, et al. "Optimisation of a Neural network Model for Calibration of Voltammetric Data", Chemometrics and Intelligent Laboratory Systems, 61, 2002, 35-49.
<i>HW</i>	BJ	WEHRENS, et al. "Calibration of an Array of Voltammetric Microelectrodes", Analytica Chimica Acta 334, 1996, 93-101.
<i>HW</i>	BK	MATOS, et al. "Modified Microelectrodes and Multivariate Calibration for Flow Injection Amperometric Simultaneous Determination of Ascorbic Acid, Dopamine, Epinephrine and Dipyrone", Analyst, 125, 2011-2015, 2000.
<i>HW</i>	BL	DIAZ-CRUZ, et al. "Application of Multivariate Curve Resolution to Voltammetric Data. Part 1. Study of Zn(II) Complexation with Some Polyelectrolytes", Journal of Electroanalytical Chemistry 393, 7-16, 1995.
<i>HW</i>	BM	MENDIETA, et al. "Application of Multivariate Curve Resolution to Voltammetric Data", Analytical Biochemistry, 240, 134-141, 1996.
<i>HW</i>	BN	DIAZ-CRUZ, et al. "Cadmium-Binding Properties of Glutathione: A Chemometrical Analysis of Voltammetric Data", Electroanal. Chem., 393, 1995, 7.
<i>HW</i>	BO	DIAZ-CRUZ, et al. "Study of the Zinc-Binding Properties of Glutathione by Differential Pulse Polarography and Multivariate Curve Resolution", Journal of Inorganic Biochemistry, 70, 1998, 91-98.
<i>HW</i>	BP	DIAZ-CRUZ, et al. "Zinc-binding properties of the C-Terminal Hexapeptide Lys-Cys-Thr-Cys-Cys-Ala from Mouse Metallothionein: Analysis by Differential Pulse Polarography and Multivariate Curve Resolution", Analytica Chimica Acta 385, 1999, 353-363.
<i>HW</i>	BQ	DIAZ-CRUZ, et al. "Complexation of Cadmium by the C-terminal hexapeptide Lys-Cys-Thr-Cys-Cys-Ala from Mouse Metallothionein: Study by differential pulse polarography and circular dichroism spectroscopy with multivariate curve resolution analysis", Analytica Chimica Acta 390, 1999, 15-25.
<i>HW</i>	BR	DIAZ-CRUZ, et al. "Differential Pulse Polarographic Study of the Pb(II) Complexation by Glutathione", Journal of Electroanalytical Chemistry, 516, 2001, 110-118.
<i>HW</i>	BS	GRABARIC, et al. "Application of Multivariate Curve Resolution to the Voltammetric Data Factor Analysis Ambiguities in the Study of Weak Consecutive Complexation of Metal Ion with Ligand", Analytica Chimica Acta, 341, 1997, 105-120.
<i>HW</i>	BT	PORRES, et al. "Multivariate Curve Resolution Analysis of Voltammetric Data Obtained at Different Time Windows: Study of the System Cd ²⁺ -nitrilotriacetic Acid", Analytica Chimica Acta 371, 1998, 23-37.
<i>HW</i>	BU	ESTEBAN, et al. "Cadmium Binding Properties of the C-Terminal Hexapeptide from Mouse Metallothionein: Study by Linear Sweep Voltammetry and Multivariate Curve Resolution Analysis", Journal of Electroanalytical Chemistry, 468, 1999, 202-212.
<i>HW</i>	BV	DIAZ-CRUZ, et al. "Multivariate Curve Resolution of Cyclic Voltammetric Data: Application to the Study of the Cadmium-Binding Properties of Glutathione", Anal. Chem., 1999, 71, 4629-2636.
<i>HW</i>	BW	FERNANDEZ, "Voltammetric Soft Modelling Approach for Systems with Both Electrochemically Labile and Inert Complexes: the Zn-Glycine Case", Electroanalysis, 2001, 13, No. 17.

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NW	BX	DIAZ-CRUZ, et al. "Soft- and Hard-Modeling Approaches for the Determination of Stability Constants of Metal-Peptide Systems by Voltammetry", Analytical Biochemistry 279, 189-201, 2000.			
	BY	FERNANDEZ, et al. "Soft Modelling Approach Applied to Voltammetric Data: Study of Electrochemically Labile Metal-Glycine Complexes", Journal of Electroanalytical Chemistry, 505, 2001, 44-53.			
	BZ	CRUZ, et al. "Multivariate Curve Resolution of Polarographic Data Applied to the Study of the Copper-Binding Ability of Tannic Acid", Analytica Chimica Acta, 424, 2000, 203-209.			
	CA	ESTEBAN, et al. "Multivariate Curve Resolution with Alternating Least Squares Optimisation: A Soft-Modelling Approach to Metal Complexation Studies by Voltammetric Techniques", Trends in Analytical Chemistry, Vol. 19, No. 1, 2000.			
	CB	BERZAS, et al. "Partial Least Squares Method in the Analysis by Square Wave Voltammetry. Simultaneous Determination of Sulphamethoxypyridazine and Trimethoprim", Analytica Chimica Acta 349, 1997, 303-311.			
	CC	SAURINA, et al. "Cyclic Voltammetric Simultaneous Determination of oxidizable Amino Acids Using Multivariate Calibration Methods", Analytica Chimica Acta, 405, 2000, 153-160.			
	CD	HERRERO, et al. "Multivariate Calibration Transfer Applied to the Routine Polarographic Determination of Copper, Lead, Cadmium and Zinc", Analytica Chimica Acta, 348, 1997, 51-59.			
	CE	HERRERO, et al. "Modelling the Background Current with Partial Least Squares Regression and transference of the Calibration Models in the Simultaneous Determination of Tl and Pb by Stripping Voltammetry", Talanta, 46, 1998, 129-138.			
	CF	HERRERO, et al. "Solving the Interference Due to Coupled Reactions in the Polarographic Determination of Benzaldehyde with Soft Modelling", Journal of Electroanalytical Chemistry, 432, 1997, 223-227.			
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	CH	HERRERO, et al. "Qualitative and quantitative Aspects of the Application of Genetic Algorithm-based Variable Selection in Polarography and Stripping Voltammetry", Analytica Chimica Acta, 378, 1999, 245-259.			
	CI	SANZ, et al. "Capability of Discrimination: Application to Soft Calibration Methods", Analytica Chimica Acta, 446, 2001, 297-311.			
	CJ	ENGBOLM, "Fourier Transform of a Reversible Linear Sweep Voltammogram", Anal. Chem., 1992, 64, 2530-2538.			
	CK	ENGBOLM, "Properties and Application of the Fourier Transform of a Voltammetric Wave", J. Electroanal. Chem., 332, 1992, 73-99.			
	CL	SIMONS, et al. "Data Processing for Amperometric Signals", Analyst, April 1995, Vol. 120.			
	CM	CHOW, et al. "Signal Enhancement of Potentiometric Stripping Analysis Using Digital Signal Processing", Analytica Chimica Acta, 307, 1995, 15-26.			
NW	CN	ECONOMOU, et al. "Data Enhancement in Adsorptive Stripping Voltammetry by the Application of Digital Signal Processing Techniques", Analyst, 119, 1994, 847.			
EXAMINER <i>Chang S. Will, Jr.</i>			DATE CONSIDERED 12/23/05		
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<i>H.W.</i>	CO	ECONOMOU & FIELDEN, "Digital Filtering in Stripping Analysis", Analytica Chimica Acta, 305, 1995, 165-175.	
	CP	DO LAGO, et al. "Applying Moving Median Digital Filter to Mass Spectrometry and Potentiometric Titration", Analytica Chimica Acta, 310, 1995, 281-288.	
	CQ	ZOU & MO, "Spline Wavelet Analysis for Voltammetric Signals", Analytica Chimica Acta, 340, 1997, 115-121.	
	CR	ZHENG & MO, "The Coupled Application of the B-Spline Wavelet and RLT Filtration in Staircase Voltammetry", Chemometrics and Intelligent Laboratory Systems, 45, 1999, 157-161.	
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	CT	BOS & LINDEN, "Automatic Polarographic Elucidation of Electrode Mechanisms by Means of a Knowledge-Based System", Anal. Chim. Acta., 231, 1990, 59.	
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	CX	ESTEBAN, et al. "Expert System for the Voltammetric Determination of Trace Metals", Analytica Chimica Acta, 268, 1992, 95.	
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	DC	GARCIA-ARMADA, et al. "Knowledge-Based System for the Provision of an Analytical Strategy for Simultaneous Determination of Metals by Differential-Pulse Polarography", Analytica Chimica Acta, 316, 1995, 47.	
	DD	GELADI & KOWALSKI, "Partial Least-Squares Regression: A Tutorial", Analytica Chimica Acta, 185, 1986, 1.	
<i>H.W.</i>	DE	WOLD, "Principal Component Analysis", Chemometrics and Intelligent Laboratory Systems, 2, 1987, 37-52.	
EXAMINER <i>D. Wiel, Jr.</i>	DATE CONSIDERED 12/23/05		
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INFORMATION DISCLOSURE CITATION Page 6 of 6		Applicant(s): Wikiel, et al.		
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HW	DF	DONAHUE & BROWN, "Successive Average Orthogonalization of Spectral Data", Anal. Chem., 1991, 63, 980-985.		
	DG	SHAH & GEMPERLINE, "Combination of the Mahalanobis Distance and Residual Variance Pattern Recognition Techniques for Classification of Near-Infrared Spectra", Anal. Chem., 62, 1990, 465.		
	DH	ROUSSEEUW & DRIESSEN, "A Fast Algorithm for the Minimum Covariance Determinant Estimator", Technometrics, 41, 1999, 212.		
	DI	EGAN & MORGAN, "Outlier Detection in Multivariate Analytical Chemical Data", Anal. Chem., 1998, 70, 2372-2379.		
	DJ	HAALAND & THOMAS, "Partial Least-Squares Methods for Spectral Analyses. 1. Relation to Other Quantitative Calibration Methods and the Extraction of Qualitative Information", Anal. Chem., 1998, 60, 1193-1208.		
	DK	KINDSVATER, et al. "Correlation of Retention Volumes of Substituted Carboranes with Molecular Properties in High Pressure Liquid Chromatography Using Factor Analysis", Analytical Chemistry, Vol. 46, No. 8, July 1974.		
	DL	EXNER, "Additive Physical Properties, I. General Relationships and Problems of Statistical Nature", Collection Czechoslov. Chem. Commun., Vol. 31, 1966.		
	DM	WANG, et al. "Multivariate Instrument Standardization", American Chemical Society, Anal. Chem., 1991, 63, 2750-2756.		
HW	DN	WANG, et al. "Additive Background Correction in Multivariate Instrument Standardization", Anal. Chem., 1995, 67, 2379-2385.		
EXAMINER <i>Danny A. Wintell</i>			DATE CONSIDERED 12/23/05	
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INFORMATION DISCLOSURE STATEMENT BY APPLICANT		Application Number	10/621,247
(use as many sheets as necessary)		Filing Date	July 16, 2003
		First Named Inventor	Wikiel, et al.
		Group Art Unit	Not Yet Assigned
		Examiner Name	Not Yet Assigned
		Attorney Docket Number	004522-00019
Sheet	1	of	1

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

Examiner Signature	Hann S. Williford	Date Considered	12/23/05
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